Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/989,662	TAKANO ET AL.	
Examiner	Art Unit	
TUAN A. PHAM	2643	

SEARCHED					
Class	Subclass	Date	Examiner		
455	436	11/8/2005	PHAM		
	442				
	439		_		
	443				
	437				
	67.11				
	524				
	561				
	522				
	525	11/8/2005	PHAM		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	Same As				
	Above				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR	
Consulted with:				
Nguyen Vo		11/8/2005	PHAM	
Binh Tieu				
· ,, .				
			·	
			:	
	,			
		•		